Search Notes

Application/Control No.	Applicant(s)/Patent Reexamination	Applicant(s)/Patent under Reexamination	
10/510,119	DIEHL ET AL.	DIEHL ET AL.	
Examiner	Art Unit		
Phillip Gambel	1644		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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RENTED CSW &	8/M07	PC		